

2, 4-CHANNEL PROTECTION SOLUTION FOR SUPER-SPEED (6 GBPS) USB 3.0 INTERFACE

Check for Samples: [TPD2EUSB30](#), [TPD2EUSB30A](#), [TPD4EUSB30](#)

FEATURES

- **Single and Dual-Pair Differential Lines to Protect the Differential Data and Clock Lines of the USB3.0, eSATA, or LVD Interface**
- **Flow-Through Pin Mapping for the High-Speed Lines Ensures near Zero Additional Skew Due to Board Layout While Placing Protection Chip Near the Connector**
- **Supports Data Rates in Excess of 6 Gbps**
- **ESD Protection Meets or Exceeds IEC61000-4-2 (Level 4)**
- **Low Capacitance 0.05pF (IO to IO)**
- **0.6 Ω Dynamic Resistance**
- **5-A Peak Pulse Current (per 8/20 μ s Pulse)**
- **Industrial Temperature Range: -40°C to 85°C**
- **Space-Saving DRT, DQA Packages**

APPLICATIONS

- **Notebooks**
- **Set-Top Boxes**
- **DVD Players**
- **Media Players**
- **Portable Computers**

DESCRIPTION/ORDERING INFORMATION

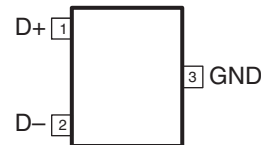
The TPD2EUSB30, TPD2EUSB30A, and TPD4EUSB30 provide 2 and 4 channel ESD and surge protection solutions in space saving, flow-through packages. These devices have been designed to protect sensitive components which are connected to ultra high-speed data and transmission lines. These devices also offer 5 A (8/20 μ s) peak pulse current ratings per IEC 61000-4-5 (lightning) specification.

The monolithic silicon technology allows matching between the differential signal pairs. The differential 0.05-pF capacitance ensures that the signal distortion due to added ESD clamp remains minimal at high-speed differential data transmission.

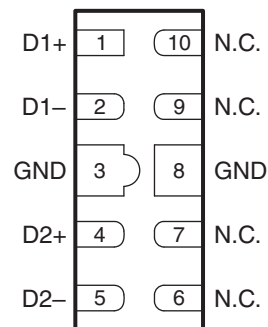
The TPD2EUSB30A offers low 4.5V dc break-down voltage. The low capacitance and break-down voltage, coupled low dynamic resistance, make the TPD2EUSB30A a superior ESD/ surge protection device for high-speed differential IOs based off ultra-low voltage process nodes.

The TPD2EUSB30 and TPD2EUSB30A are offered in space saving DRT (1 mm \times 1 mm) package. The TPD4EUSB30 is offered in space saving DQA (1 mm \times 2.5 mm) package. These devices are characterized for operation over ambient air temperature range of -40°C to 85°C .

**DRT PACKAGE
(TOP VIEW)**



**DQA PACKAGE
(TOP VIEW)**



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

ORDERING INFORMATION

T _A	PACKAGE ⁽¹⁾ ⁽²⁾		ORDERABLE PART NUMBER	TOP-SIDE MARKING ⁽³⁾
-40°C to 85°C	SOT – DRT	Tape and reel	TPD2EUSB30DRTR	5P
	SOT – DRT	Tape and reel	TPD2EUSB30ADRTR	5S
	SON – DQA	Tape and reel	TPD4EUSB30DQAR	66_

- (1) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.
- (2) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.
- (3) DQA: The actual top-side marking has one additional character that designates wafer fab/assembly site.

CIRCUIT DIAGRAMS

Figure 1. TPD4EUSB30 Circuit

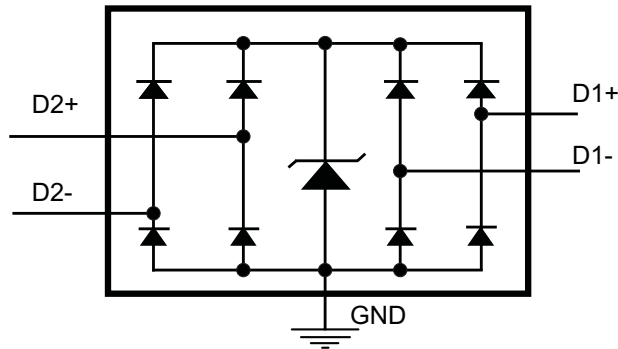
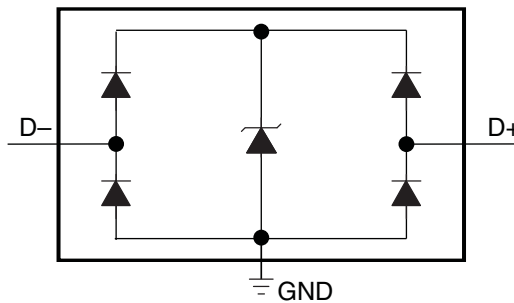


Figure 2. TPD2EUSB30/A Circuit



TERMINAL FUNCTIONS

NAME	TERMINAL		TYPE	DESCRIPTION
	DRT PIN NO.	DQA PIN NO.		
Dx+, Dx-	1, 2	1,2, 4, 5	ESD port	High-speed ESD clamp, provides ESD protection to the high-speed differential data lines
GND	3	3, 8	GND	Ground
N.C.		6, 7, 9, 10		Not normally connected

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
	IO voltage tolerance	D+, D– pins	0	6	
T _A	Operating free-air temperature range		–40	85	°C
T _{stg}	Storage temperature range		–65	125	°C
ESD protection	IEC 61000-4-2 Contact Discharge	D+, D– pins		±8	kV
	IEC 61000-4-2 Air-Gap Discharge (TPD2EUSB30/A)	D+, D– pins		±8	kV
	IEC 61000-4-2 Air-Gap Discharge (TPD4EUSB30)	D+, D– pins		±9	kV
	Peak pulse current (t _p = 8/20 μs)	D+, D– pins		5	A
	Peak pulse power (t _p = 8/20 μs)	D+, D– pins		45	W

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum-rated conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
V _{RWM}	Reverse stand-off voltage, TPD2EUSB30, TPD4EUSB30	D+, D– pins to ground				5.5	V
	Reverse stand-off voltage, TPD2EUSB30A	D+, D– pins to ground				3.6	V
V _{clamp}	Clamp voltage	D+, D– pins to ground, I _{IO} = 1 A				8	V
I _{IO}	Current from IO port to supply pins	V _{IO} = 2.5 V,	I _D = 8 mA		0.01	0.1	μA
V _D	Diode forward voltage	D+, D– pins, lower clamp diode,	V _{IO} = 2.5 V, I _D = 8 mA	0.6	0.8	0.95	V
R _{dyn}	Dynamic resistance	D+, D– pins I = 1 A			0.6		Ω
C _{IO-IO}	Capacitance IO to IO	D+, D– pins V _{IO} = 2.5 V			0.05		pF
C _{IO-GND}	Capacitance IO to GND	D+, D– pins (DRT)			0.7		pF
		D1+, D1-, D2+, D2- (DQA)		V _{IO} = 2.5 V	0.8		
V _{BR}	Break-down voltage, TPD2EUSB30, TPD4EUSB30	I _{IO} = 1 mA		7			V
	Break-down voltage, TPD2EUSB30A	I _{IO} = 1 mA		4.5			V

TYPICAL OPERATING CHARACTERISTICS

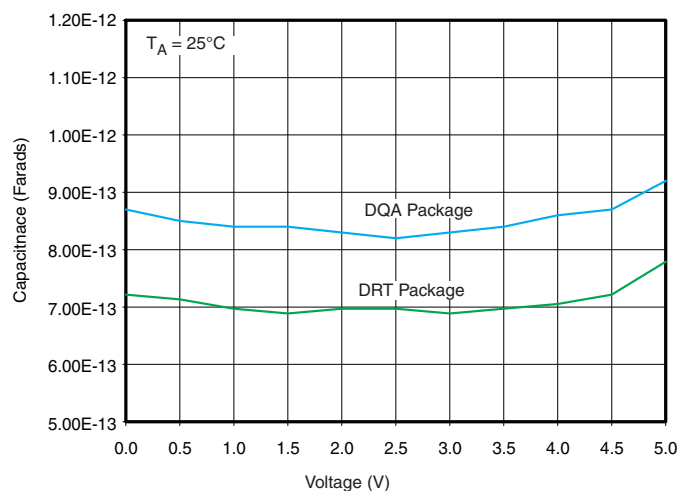


Figure 3. IO Capacitance vs IO Voltage

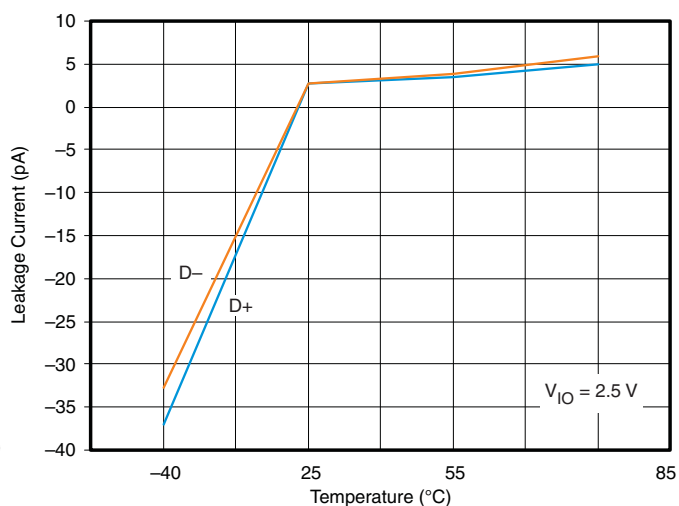


Figure 4. Leakage Current vs Temperature

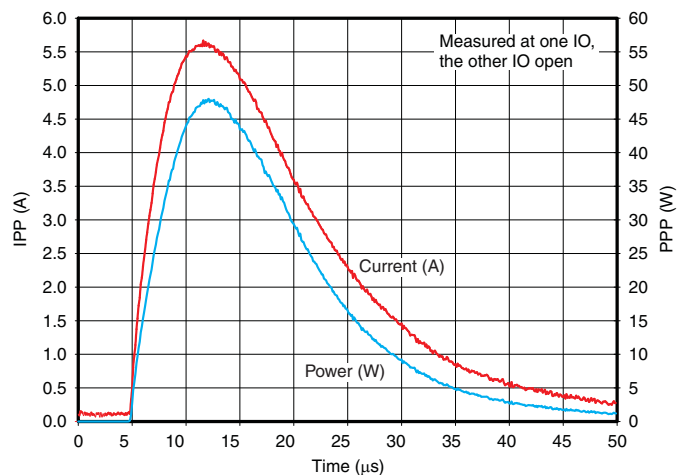


Figure 5. Peak Pulse Waveforms

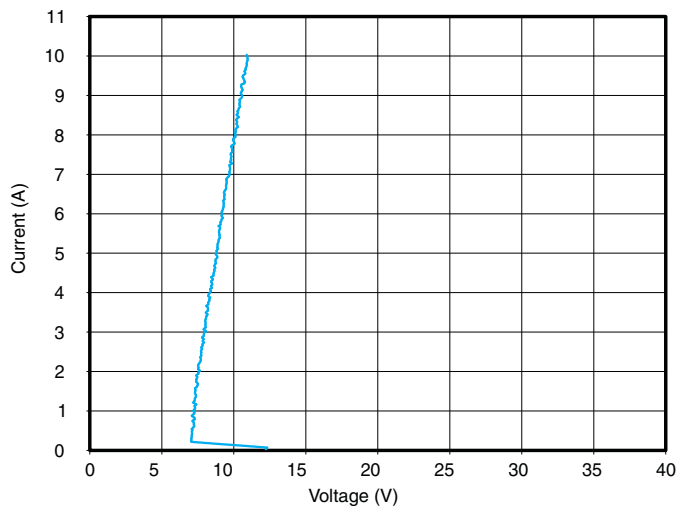


Figure 6. D+, D- Transmission Line Pulsar Plot for TPD2EUSB30 (100 ns Pulse, 10 ns Rise Time)

TYPICAL OPERATING CHARACTERISTICS (continued)

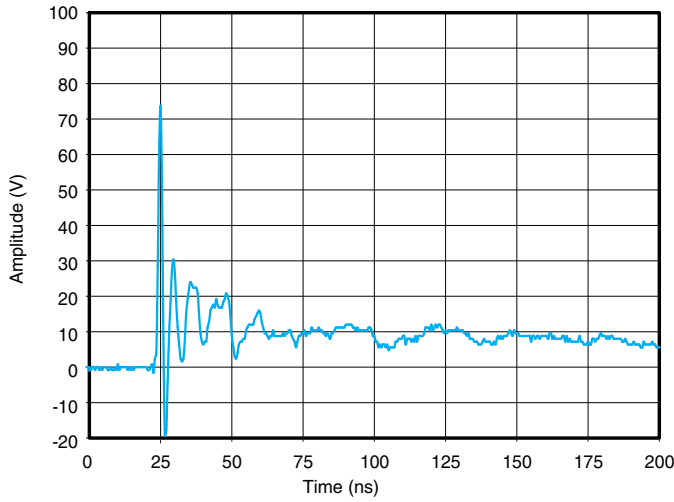


Figure 7. IEC Clamping Waveforms (8 kV Contact)

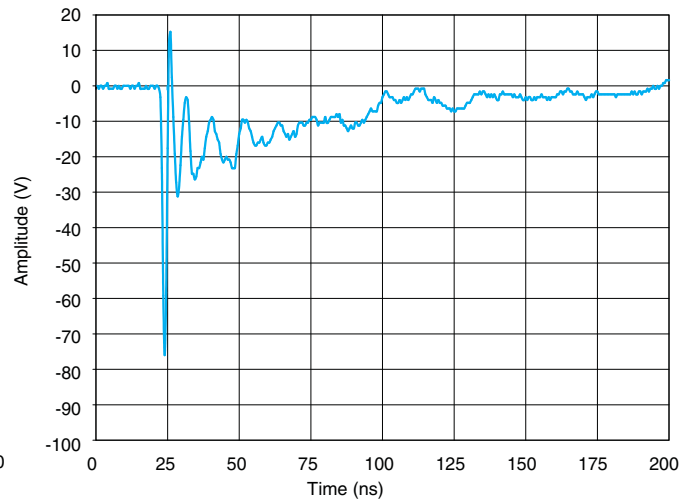


Figure 8. IEC Clamping Waveforms (-8 kV Contact)

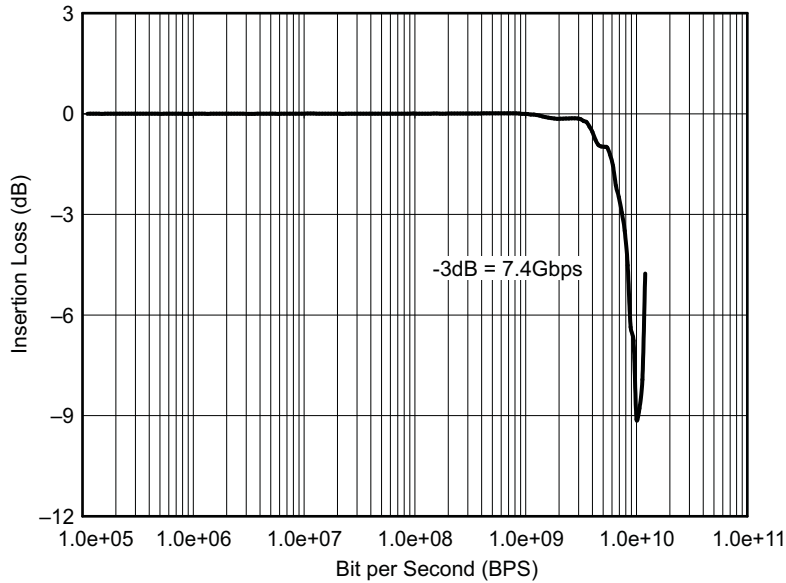


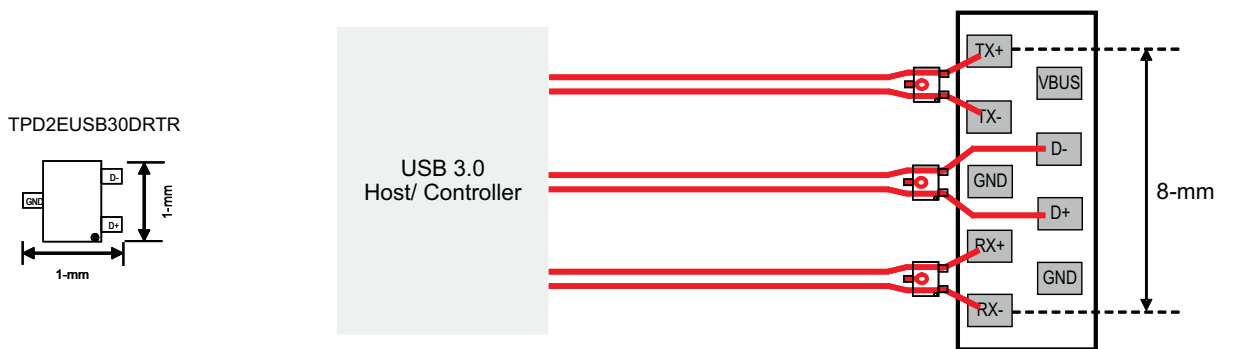
Figure 9. Insertion Loss

APPLICATION INFORMATION

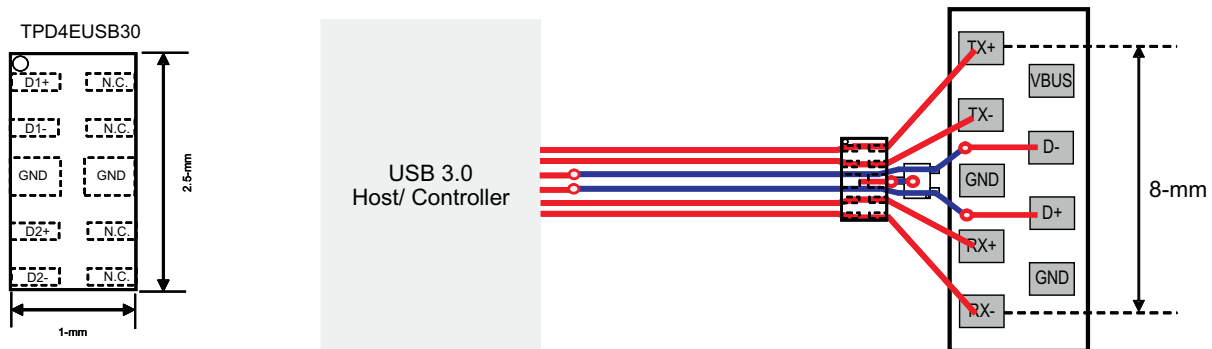
Layout Guide with TPDxEUSB30/A

Refer to [Figure 10](#), the TPD2EUSB30/A are offered in space saving DRT package. The DRT is a 1mm* 1mm package with flow-through pin-mapping for the high-speed differential lines. The TPD4EUSB30 is offered in space saving DQA package. The DQA is a 1mm* 2.5mm package with flow-through pin-mapping for the high-speed differential lines. It is recommended to place the package right next to the USB 3.0 connector. The GND pin should be connected to GND plane of the board through a large VIA. If a dedicated GND plane is not present right underneath, it is recommended to route to the GND plane through a wide trace. The current associated with IEC ESD stress can be in the range of 30Amps or higher momentarily. A good, low impedance GND path ensures the system robustness against IEC ESD stress.

The TPDxEUSB30/A can provide system level ESD protection to the high-speed differential ports (>6 Gbps data rate). The flow-through package offers flexibility for board routing with traces up to 15 mils wide. It allows the differential signal pairs couple together right after they touch the ESD ports of the TPDxEUSB30/A.



Three TPD2EUSB30 to Protect USB3.0 Class A connector (One Layer Routing)



One TPD4EUSB30 & One TPD2EUSB30 to Protect USB3.0 Class A connector (Two Layer Routing)

Figure 10. Layout Guide with the TPDxEUSB30/A at the USB3.0 Class A Connector

TPDxEUSB30/A Eye Pattern Test

See [Figure 12](#) for a demonstration of the TPDxEUSB30/A performance the lab set-up. [Figure 11](#) shows a lab board that was designed to demonstrate the degradation of the eye pattern quality with and without the TPD2EUSB30/A in the USB 3.0 signal path. [Figure 13](#) shows that there is only ~2 ps jitter penalty to the differential signal when the TPD2EUSB30/A device was added in the signal path. Similar setup was employed to measure eye pattern for the TPD4EUSB30.

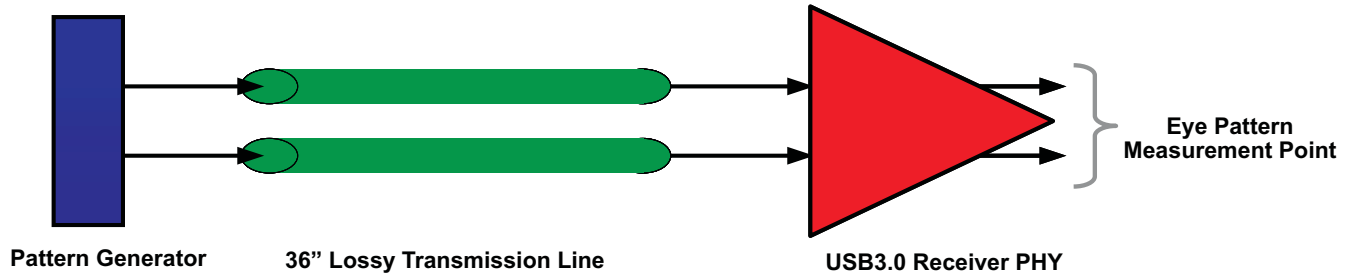


Figure 11. Measurement Setup to collect the Eye Pattern on a Reference Board with TPD2EUSB30/A

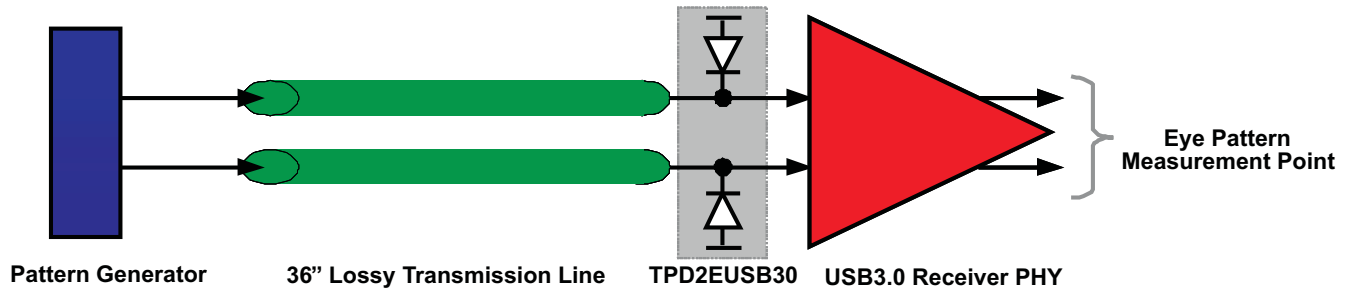


Figure 12. Measurement Setup to collect the Eye Pattern on a Reference Board with TPD2EUSB30/A

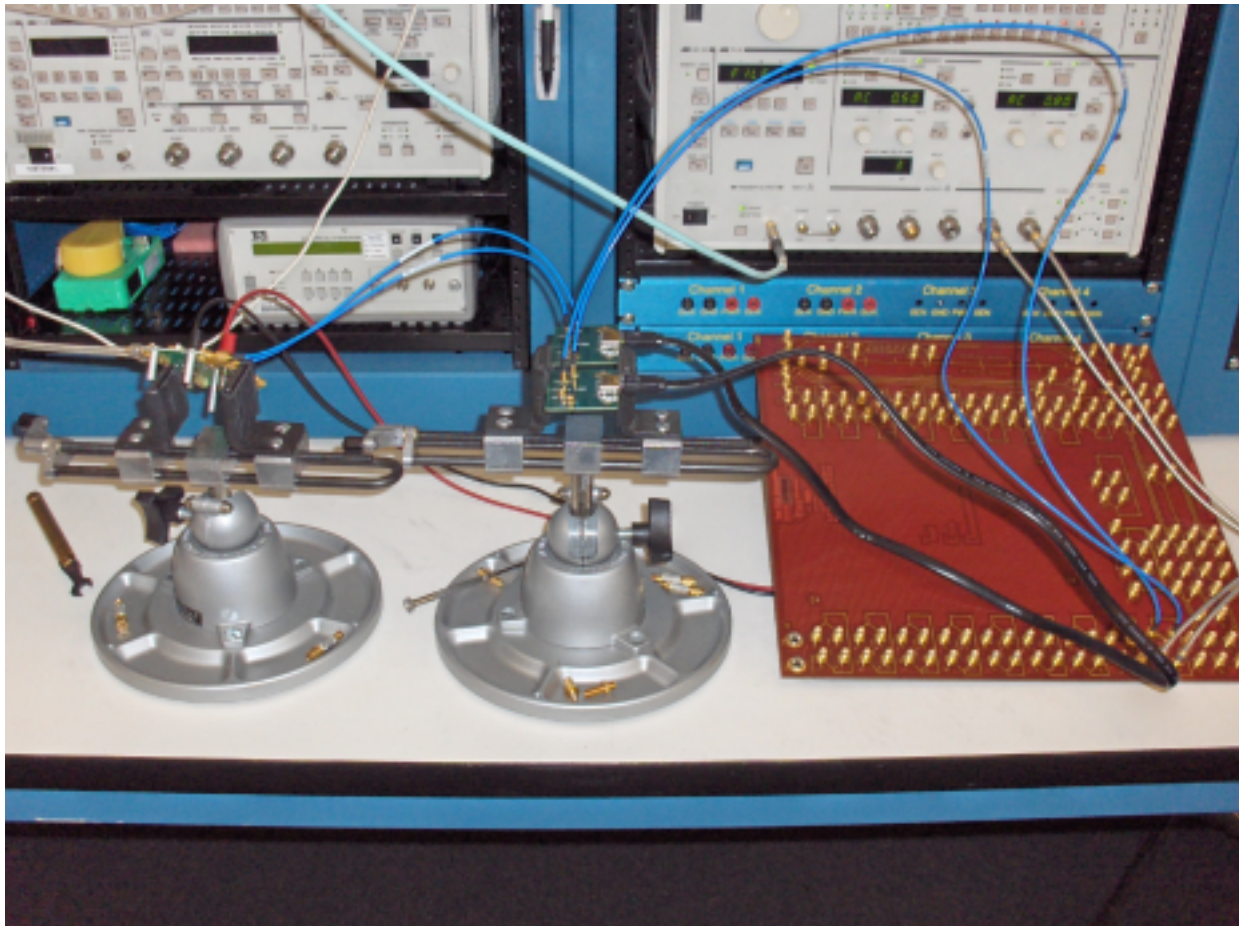


Figure 13. Lab Setup for the Eye-Pattern Measurement with TPDxUSB30/A

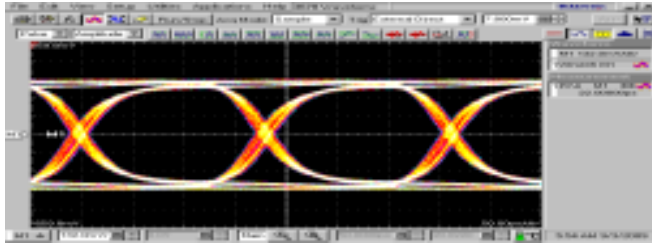


Figure 14. Output Eye Diagram Without TPD2EUSB30/A (Figure 11 Setup, 5 Gbps Data Rate)

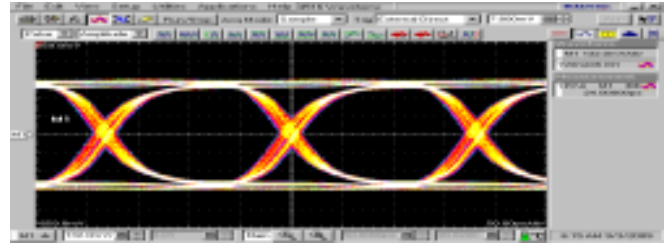


Figure 15. Output Eye Diagram with the TPD2EUSB30/A (Figure 11 Setup, 5 Gbps Data Rate)

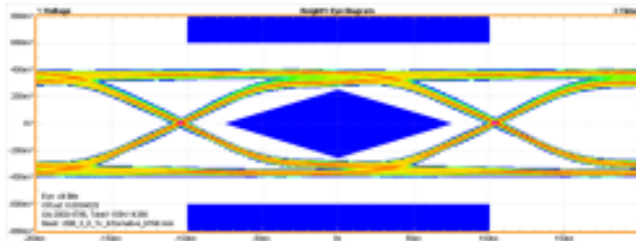


Figure 16. Output Eye Diagram Without the TPD4EUSB30 (5 Gbps Data Rate)

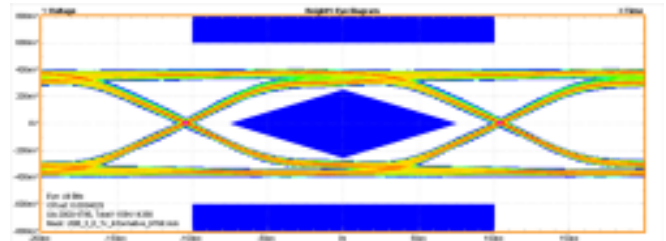


Figure 17. Output Eye Diagram with the TPD4EUSB30 (5 Gbps Data Rate)

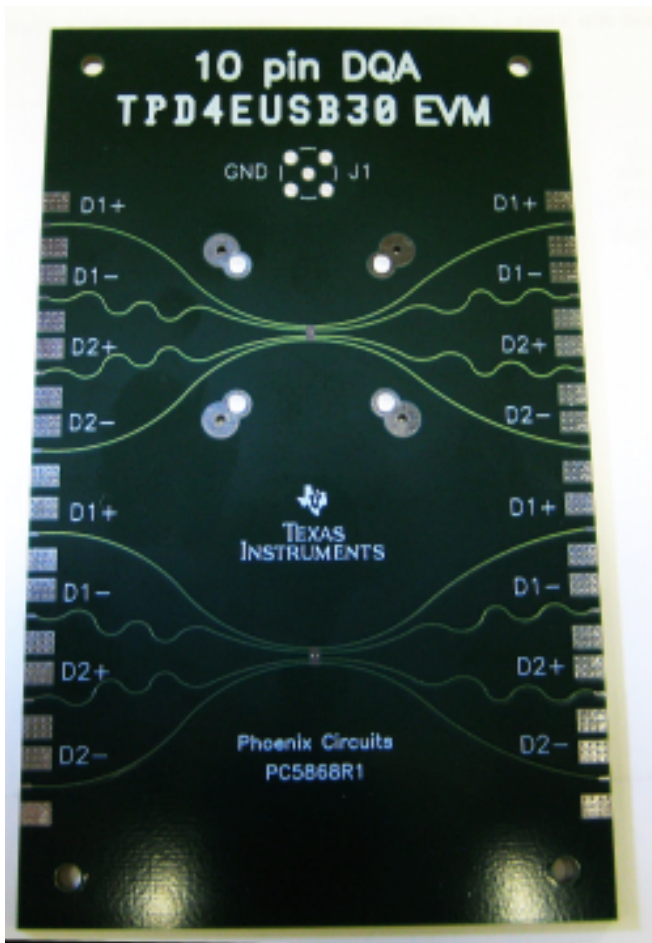


Figure 18. TPDxUSB30/A EVM – TPD4EUSB30 Side

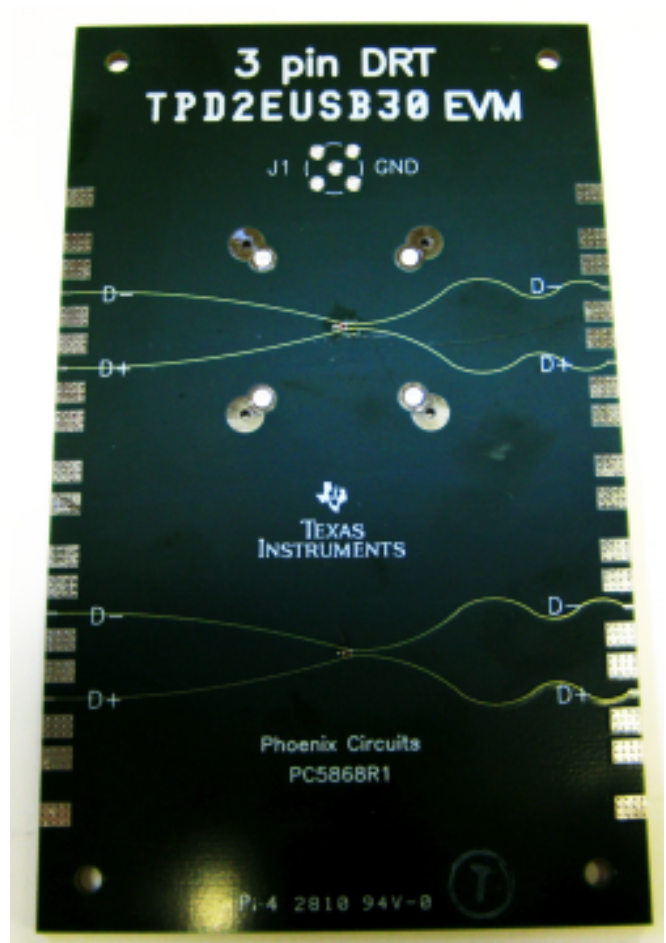


Figure 19. TPDxUSB30/A EVM – TPD2EUSB30/A Side

REVISION HISTORY

Changes from Original (August 2010) to Revision A	Page
<ul style="list-style-type: none">Added TPS2EUSB30A part to document.	1
Changes from Revision A (December 2010) to Revision B	Page
<ul style="list-style-type: none">Changed TOP-SIDE MARKING column in the Ordering Information Table.	2
Changes from Revision B (July 2011) to Revision C	Page
<ul style="list-style-type: none">Added Insertion Loss graphic to TYPICAL OPERATING CHARACTERISTICS section.	5
Changes from Revision December 2011 (C) to Revision D	Page
<ul style="list-style-type: none">Updated Dynamic Resistance value.Updated Dynamic Resistance value.	1 3

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPD2EUSB30ADRTR	ACTIVE	SOT	DRT	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	5S	Samples
TPD2EUSB30DRTR	ACTIVE	SOT	DRT	3	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	5P	Samples
TPD4EUSB30DQAR	ACTIVE	USON	DQA	10	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(667 ~ 66O ~ 66R)	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION



QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



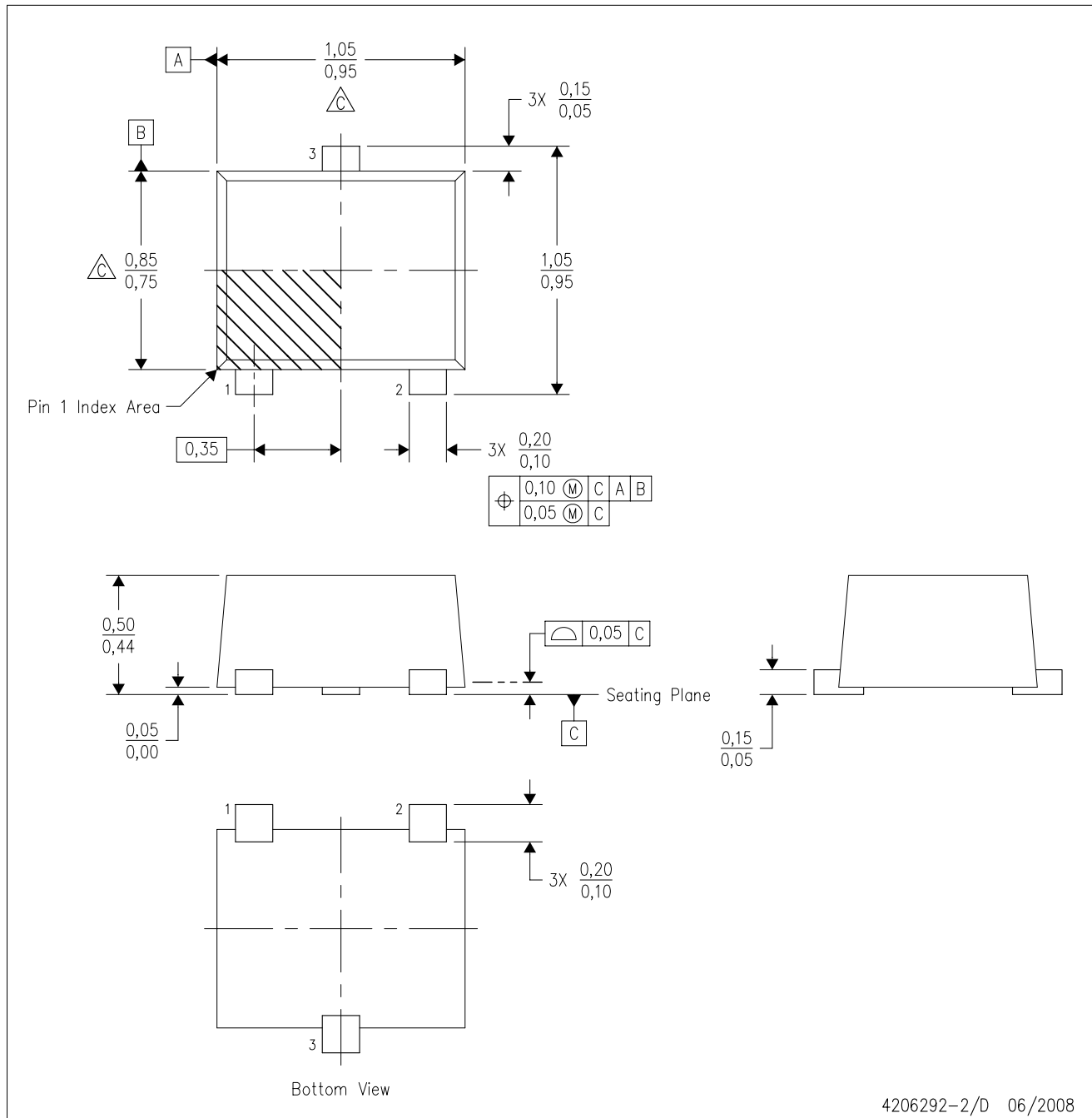
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPD2EUSB30ADRTR	SOT	DRT	3	3000	180.0	8.4	1.16	1.16	0.63	4.0	8.0	Q3
TPD2EUSB30DRTR	SOT	DRT	3	3000	180.0	8.4	1.16	1.16	0.63	4.0	8.0	Q3
TPD4EUSB30DQAR	USON	DQA	10	3000	180.0	8.4	1.3	2.83	0.65	4.0	8.0	Q1
TPD4EUSB30DQAR	USON	DQA	10	3000	179.0	8.4	1.25	2.8	0.7	4.0	8.0	Q1
TPD4EUSB30DQAR	USON	DQA	10	3000	180.0	9.5	1.23	2.7	0.7	4.0	8.0	Q1

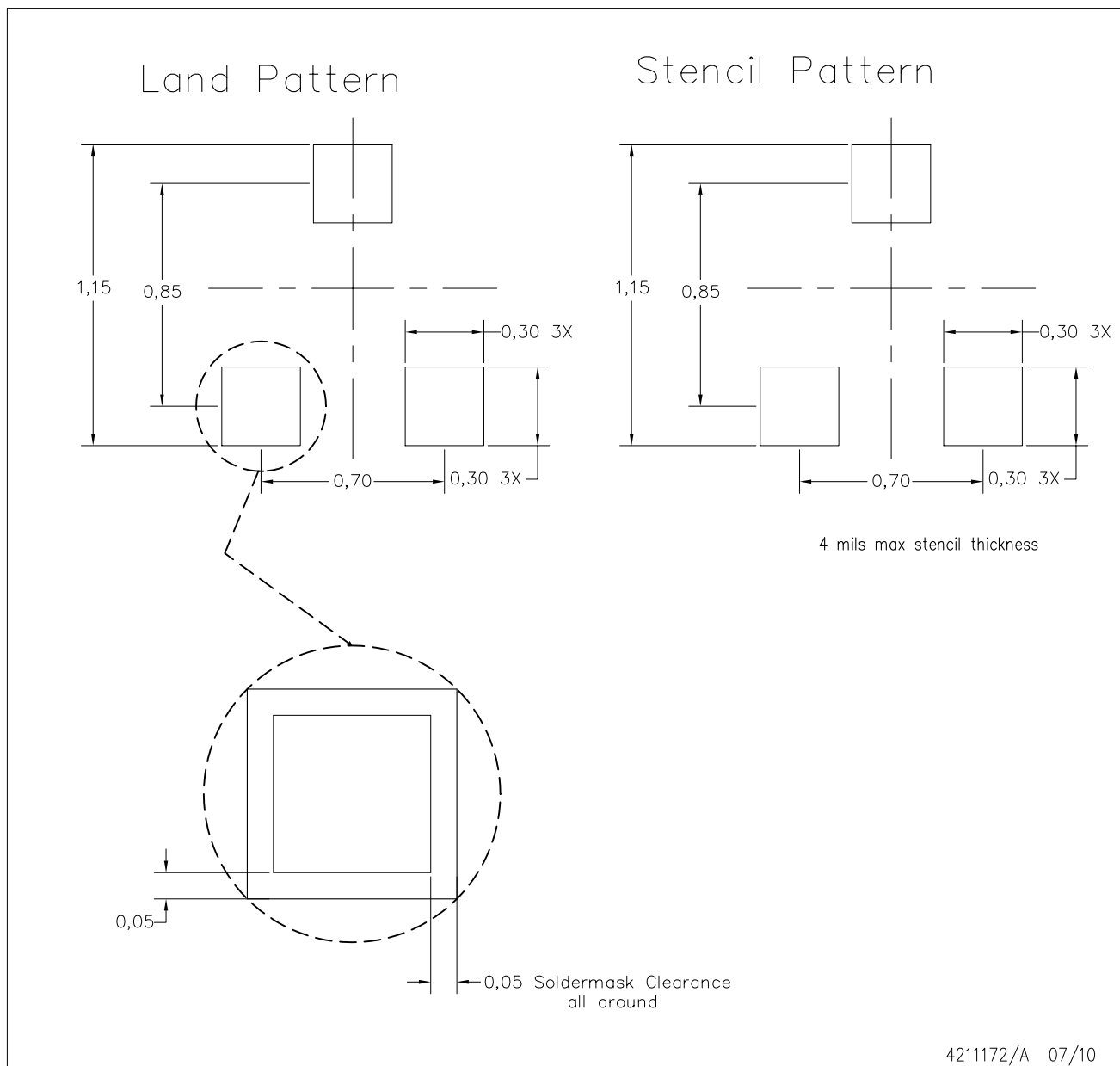
TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPD2EUSB30ADRTR	SOT	DRT	3	3000	202.0	201.0	28.0
TPD2EUSB30DRTR	SOT	DRT	3	3000	202.0	201.0	28.0
TPD4EUSB30DQAR	USON	DQA	10	3000	202.0	201.0	28.0
TPD4EUSB30DQAR	USON	DQA	10	3000	203.0	203.0	35.0
TPD4EUSB30DQAR	USON	DQA	10	3000	184.0	184.0	19.0



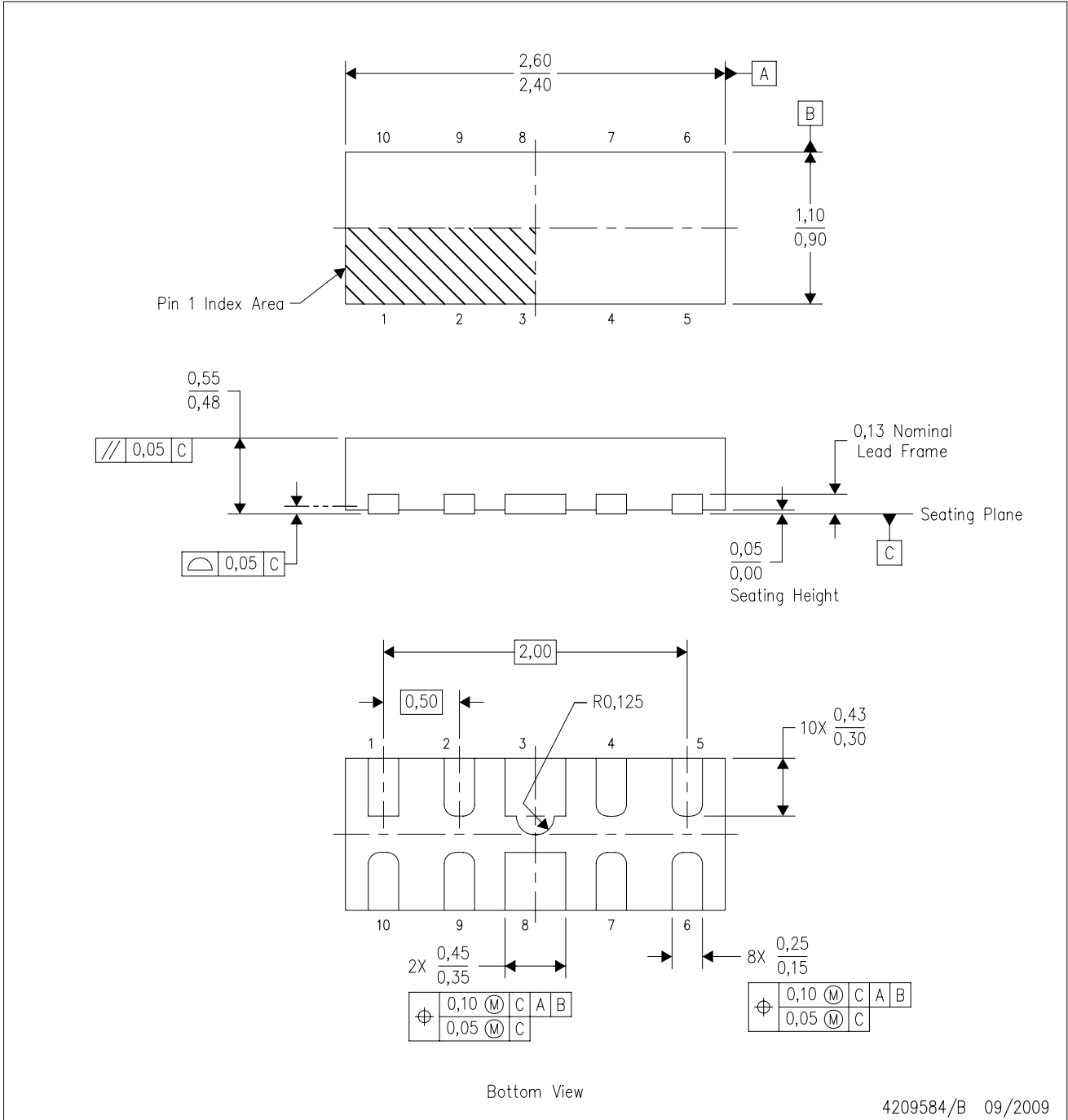
- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash, interlead flash, protrusions, or gate burrs. Mold flash, interlead flash, protrusions, or gate burrs shall not exceed 0,10 per end or side.
 - D. JEDEC package registration is pending.



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.
 - E. Maximum stencil thickness 0,1016 mm (4 mils). All linear dimensions are in millimeters.
 - F. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - G. Side aperture dimensions over-print land for acceptable area ratio > 0.66. Customer may reduce side aperture dimensions if stencil manufacturing process allows for sufficient release at smaller opening.

DQA (R-PSON-N10)

PLASTIC SMALL OUTLINE NO-LEAD



4209584/B 09/2009

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. SON (Small Outline No-Lead) package configuration.

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In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have **not** been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products

Audio	www.ti.com/audio
Amplifiers	amplifier.ti.com
Data Converters	dataconverter.ti.com
DLP® Products	www.dlp.com
DSP	dsp.ti.com
Clocks and Timers	www.ti.com/clocks
Interface	interface.ti.com
Logic	logic.ti.com
Power Mgmt	power.ti.com
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RFID	www.ti-rfid.com
OMAP Applications Processors	www.ti.com/omap
Wireless Connectivity	www.ti.com/wirelessconnectivity

Applications

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